

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/796,694 | | Applicant(s)/Patent Under Reexamination CHIANG ET AL. | |
| | Examiner Hoa C. Nguyen | | Art Unit 2841 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,726,615 | 04-2004 | Lang et al. | 493/405 |
| * | B | US-6,759,936 | 07-2004 | Yeh et al. | 336/90 |
| * | C | US-5,175,525 | 12-1992 | Smith, David A. | 336/83 |
| * | D | US-5,010,314 | 04-1991 | Estrov, Alexander | 336/198 |
| * | E | US-6,388,551 | 05-2002 | Morikawa, Takehiko | 336/223 |
| * | F | US-6,198,374 | 03-2001 | Abel, David A. | 336/200 |
| * | G | US-2005/0190035 | 09-2005 | Wang, Albert Z.H. | 336/200 |
| * | H | US-6,914,508 | 07-2005 | Ferencz et al. | 336/200 |
| * | I | US-5,521,573 | 05-1996 | Inoh et al. | 336/180 |
| * | J | US-6,211,767 | 04-2001 | Jitaru, Ionel | 336/200 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.